

N-channel 100 V, 0.0034 Ω typ., 110 A, STripFET™ F7 Power MOSFET in a H²PAK-2 package

Datasheet - production data

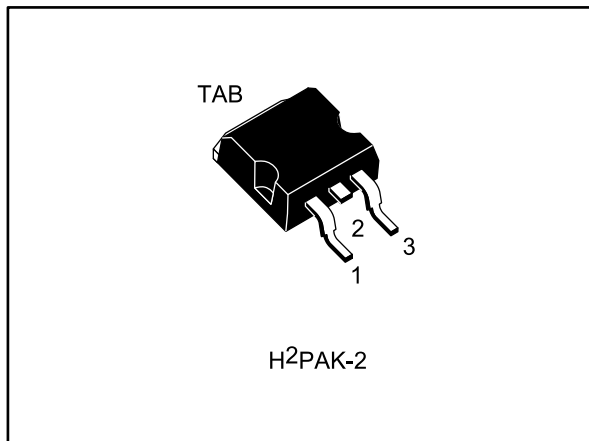


Figure 1: Internal schematic diagram

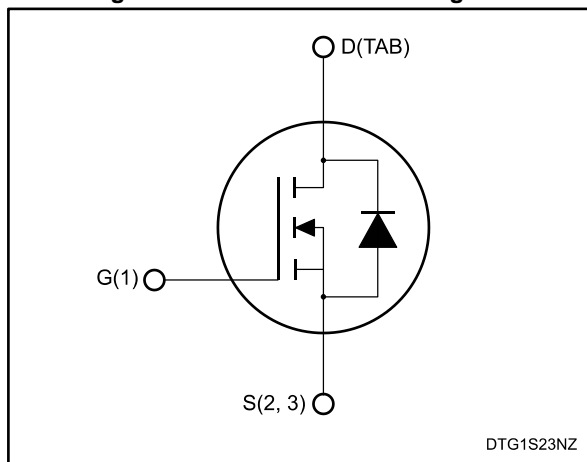


Table 1: Device summary

| Order code | Marking | Package | Packaging |
|------------|---------|----------------------|---------------|
| STH15810-2 | 15810 | H ² PAK-2 | Tape and reel |

Features

| Order code | V _{DS} | R _{DS(on)max} | I _D | P _{TOT} |
|------------|-----------------|------------------------|----------------|------------------|
| STH15810-2 | 100 V | 0.0039 Ω | 110 A | 250 W |

- 100% avalanche tested
- Ultra low on-resistance

Applications

- Switching applications

Description

This N-channel Power MOSFET utilizes STripFET™ F7 technology with an enhanced trench gate structure that results in very low on-state resistance, while also reducing internal capacitance and gate charge for faster and more efficient switching.

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1 Electrical ratings

Table 2: Absolute maximum ratings

| Symbol | Parameter | Value | Unit |
|----------------|---|------------|------------------|
| V_{DS} | Drain-source voltage | 100 | V |
| V_{GS} | Gate- source voltage | ± 20 | V |
| I_D | Drain current (continuous) at $T_C = 25\text{ }^\circ\text{C}$ | 110 | A |
| I_D | Drain current (continuous) at $T_C = 100\text{ }^\circ\text{C}$ | 110 | A |
| $I_{DM}^{(1)}$ | Drain current (pulsed) $T_C = 25\text{ }^\circ\text{C}$ | 440 | A |
| P_{TOT} | Total dissipation at $T_C = 25\text{ }^\circ\text{C}$ | 250 | W |
| $E_{AS}^{(2)}$ | Single pulse avalanche energy | 495 | mJ |
| T_J | Operating junction temperature range | -55 to 175 | $^\circ\text{C}$ |
| T_{stg} | Storage temperature range | | |

Notes:

⁽¹⁾Pulse width is limited by safe operating area

⁽²⁾Starting $T_J=25\text{ }^\circ\text{C}$, $I_D=30\text{ A}$, $V_{DD}=50\text{ V}$

Table 3: Thermal data

| Symbol | Parameter | Value | Unit |
|---------------------|--------------------------------------|-------|--------------------|
| $R_{thj-case}$ | Thermal resistance junction-case max | 0.6 | $^\circ\text{C/W}$ |
| $R_{thj-pcb}^{(1)}$ | Thermal resistance junction-pcb max | 35 | $^\circ\text{C/W}$ |

Notes:

⁽¹⁾When mounted on 1 inch² FR-4 board, 2 oz Cu

2 Electrical characteristics

($T_C = 25\text{ }^\circ\text{C}$ unless otherwise specified)

Table 4: On /off states

| Symbol | Parameter | Test conditions | Min. | Typ. | Max. | Unit |
|---------------|-----------------------------------|---|------|--------|--------|---------------|
| $V_{(BR)DSS}$ | Drain-source breakdown voltage | $V_{GS} = 0, I_D = 250\ \mu\text{A}$ | 100 | | | V |
| I_{DSS} | Zero gate voltage drain current | $V_{GS} = 0, V_{DS} = 100\ \text{V}$ | | | 1 | μA |
| | | $V_{GS} = 0, V_{DS} = 100\ \text{V}, T_C = 125\text{ }^\circ\text{C}^{(1)}$ | | | 100 | μA |
| I_{GSS} | Gate-body leakage current | $V_{DS} = 0, V_{GS} = +20\ \text{V}$ | | | 100 | nA |
| $V_{GS(th)}$ | Gate threshold voltage | $V_{DS} = V_{GS}, I_D = 250\ \mu\text{A}$ | 2.5 | | 4.5 | V |
| $R_{DS(on)}$ | Static drain-source on-resistance | $V_{GS} = 10\ \text{V}, I_D = 55\ \text{A}$ | | 0.0034 | 0.0039 | Ω |

Notes:

⁽¹⁾Defined by design, not subject to production test.

Table 5: Dynamic

| Symbol | Parameter | Test conditions | Min. | Typ. | Max. | Unit |
|------------|------------------------------|--|------|------|------|------|
| C_{iss} | Input capacitance | $V_{DS} = 50\ \text{V}, f = 1\ \text{MHz}, V_{GS} = 0$ | - | 8115 | - | pF |
| C_{oss} | Output capacitance | | - | 1510 | - | pF |
| C_{riss} | Reverse transfer capacitance | | - | 67 | - | pF |
| Q_g | Total gate charge | $V_{DD} = 50\ \text{V}, I_D = 110\ \text{A}, V_{GS} = 10\ \text{V}$ (see Figure 14: "Test circuit for gate charge behavior") | - | 117 | - | nC |
| Q_{gs} | Gate-source charge | | - | 47 | - | nC |
| Q_{gd} | Gate-drain charge | | - | 26 | - | nC |

Table 6: Switching times

| Symbol | Parameter | Test conditions | Min. | Typ. | Max. | Unit |
|--------------|---------------------|--|------|------|------|------|
| $t_{d(on)}$ | Turn-on delay time | $V_{DD} = 50\ \text{V}, I_D = 55\ \text{A}, R_G = 4.7\ \Omega, V_{GS} = 10\ \text{V}$ (see Figure 13: "Test circuit for resistive load switching times") | - | 33 | - | ns |
| t_r | Rise time | | - | 57 | - | ns |
| $t_{d(off)}$ | Turn-off delay time | | - | 72 | - | ns |
| t_f | Fall time | | - | 33 | - | ns |

Table 7: Source drain diode

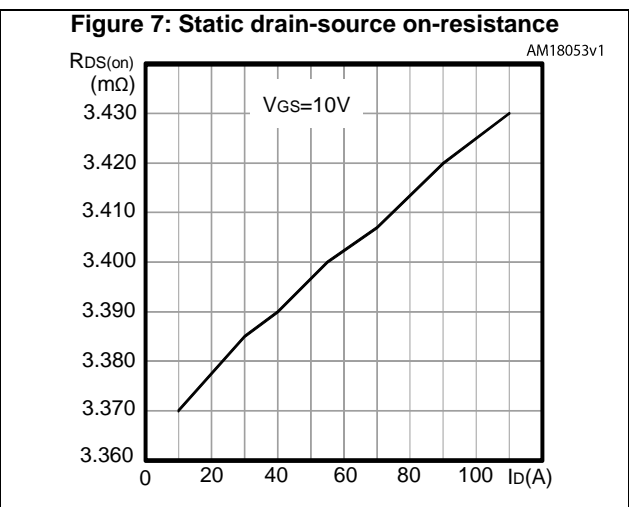
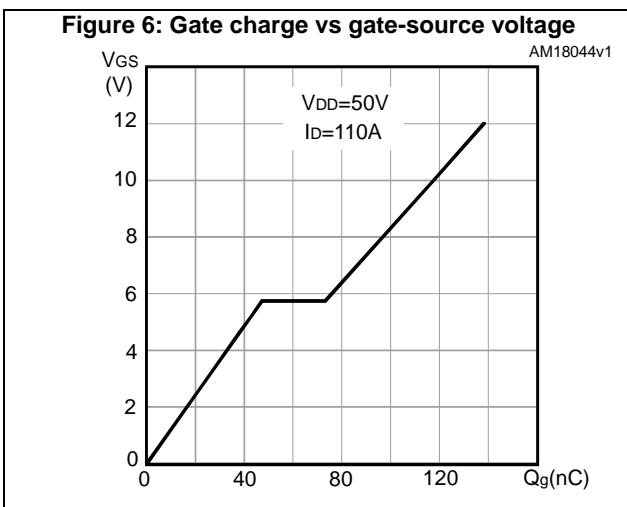
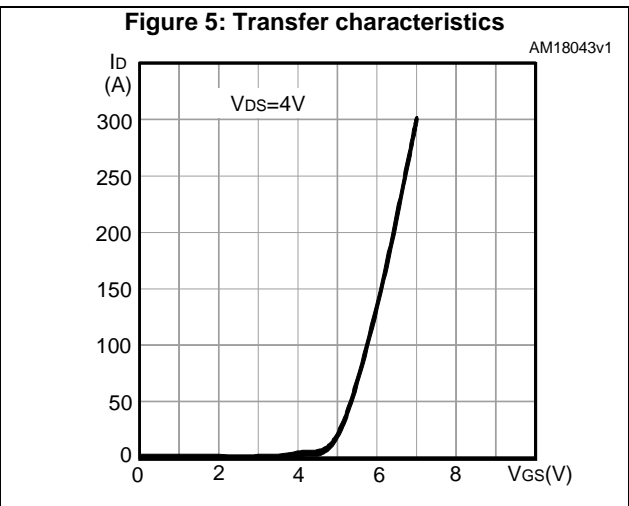
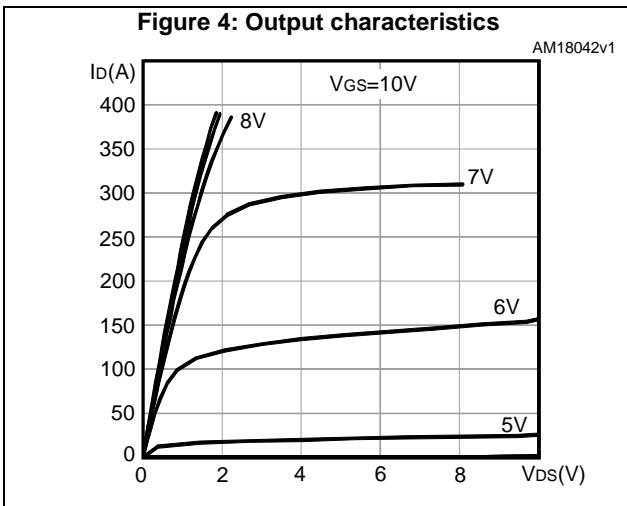
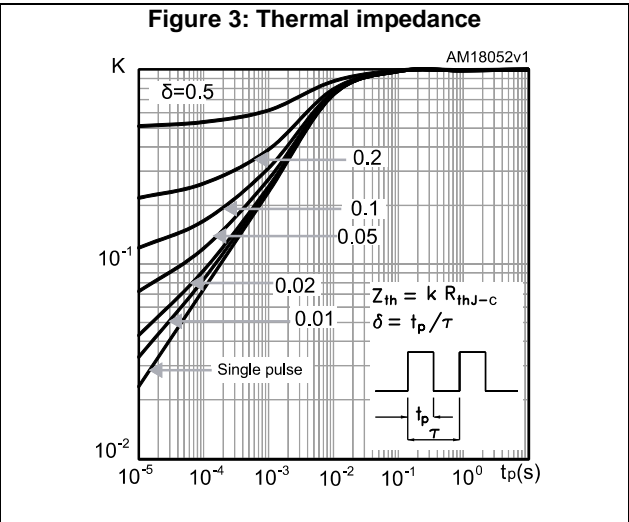
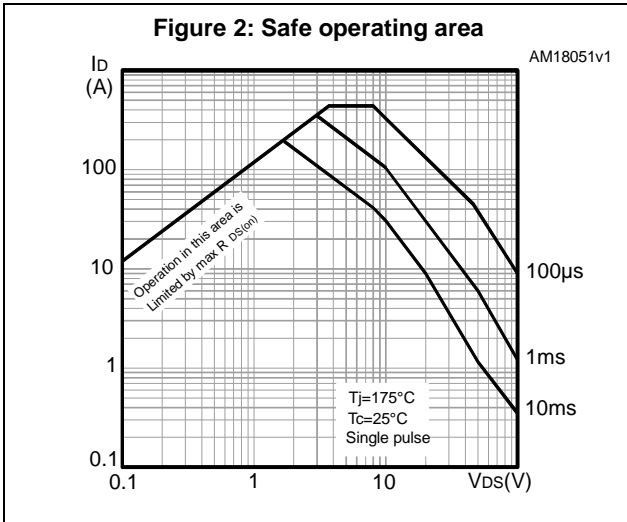
| Symbol | Parameter | Test conditions | Min. | Typ. | Max. | Unit |
|-----------------|-------------------------------|---|------|------|------|------|
| I_{SD} | Source-drain current | | - | | 110 | A |
| $I_{SDM}^{(1)}$ | Source-drain current (pulsed) | | - | | 440 | A |
| $V_{SD}^{(2)}$ | Forward on voltage | $I_{SD} = 110 \text{ A}$, $V_{GS} = 0$ | - | | 1.2 | V |
| t_{rr} | Reverse recovery time | $I_{SD} = 110 \text{ A}$, $di/dt = 100 \text{ A}/\mu\text{s}$ $V_{DD} = 80 \text{ V}$, $T_J = 150 \text{ }^\circ\text{C}$ (see Figure 15: "Test circuit for inductive load switching and diode recovery times") | - | 70 | | ns |
| Q_{rr} | Reverse recovery charge | | - | 165 | | nC |
| I_{RRM} | Reverse recovery current | | - | 4.7 | | A |

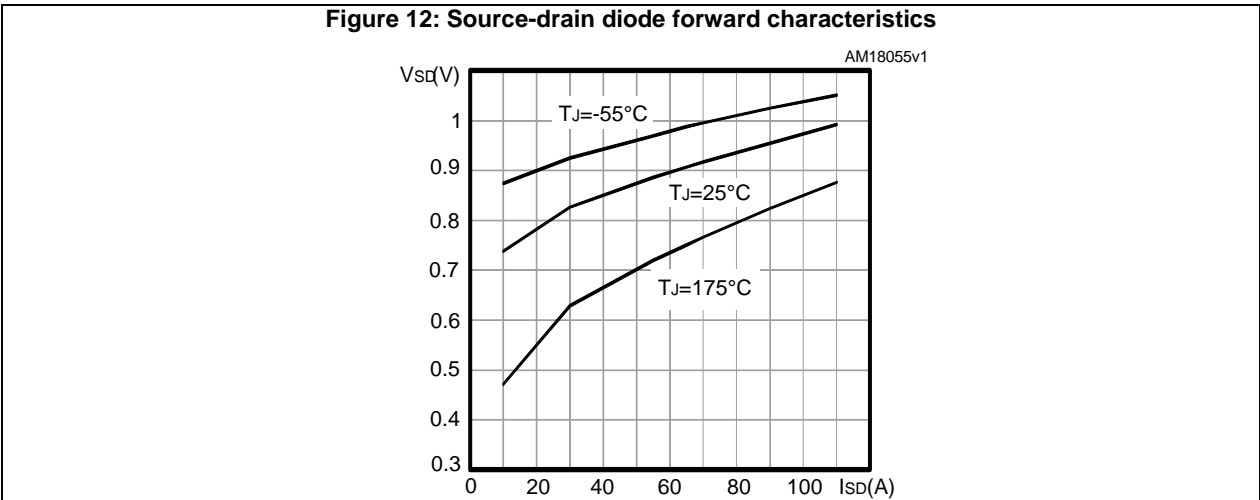
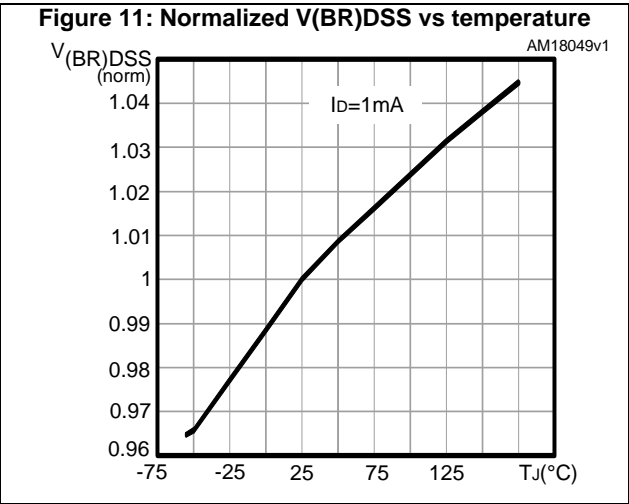
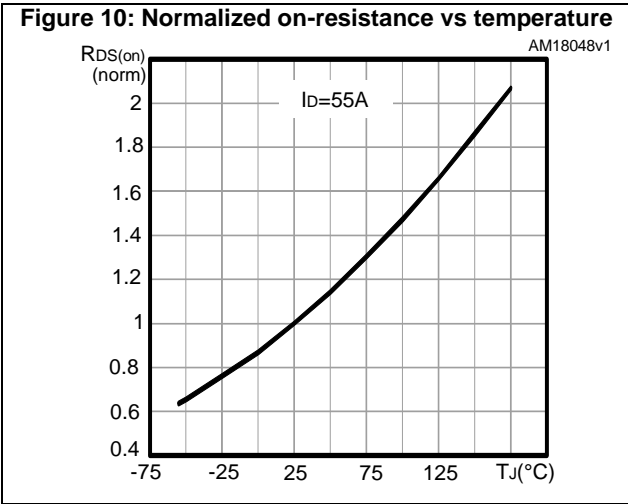
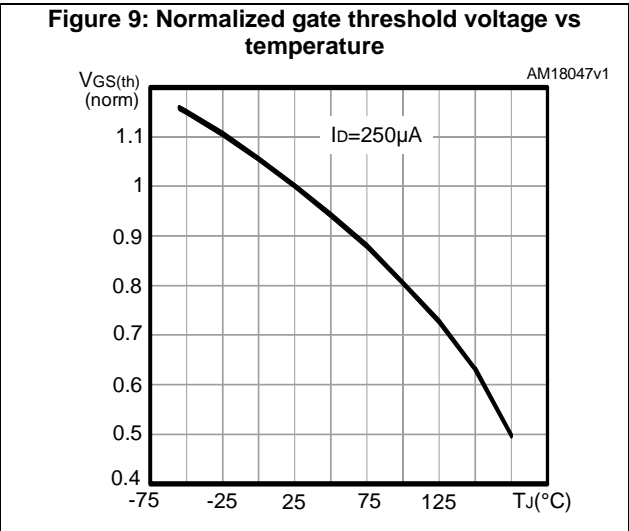
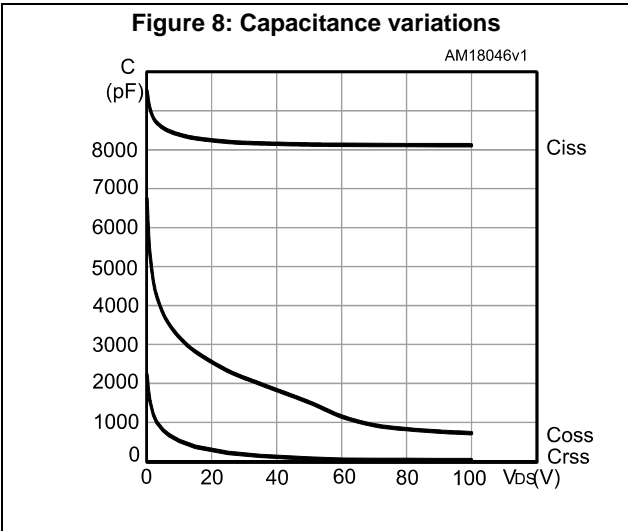
Notes:

(1)Pulse width limited by safe operating area

(2)Pulsed: pulse duration = 300 μs , duty cycle 1.5%.

2.1 Electrical characteristics (curves)





3 Test circuits

Figure 13: Test circuit for resistive load switching times



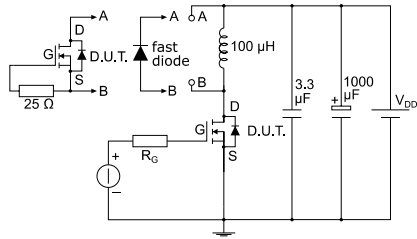
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Figure 14: Test circuit for gate charge behavior



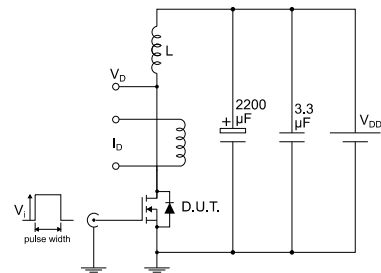
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Figure 15: Test circuit for inductive load switching and diode recovery times



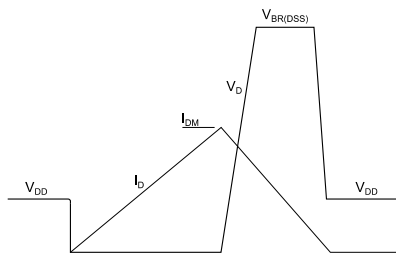
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Figure 16: Unclamped inductive load test circuit



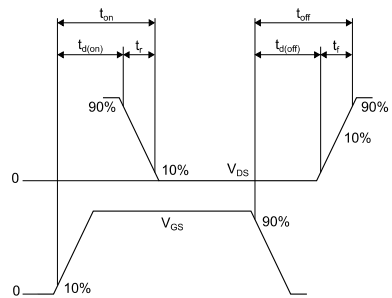
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Figure 17: Unclamped inductive waveform



AM01472v1

Figure 18: Switching time waveform



AM01473v1

4 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: www.st.com. ECOPACK® is an ST trademark.

4.1 H²PAK-2 package information

Figure 19: H²PAK-2 package outline

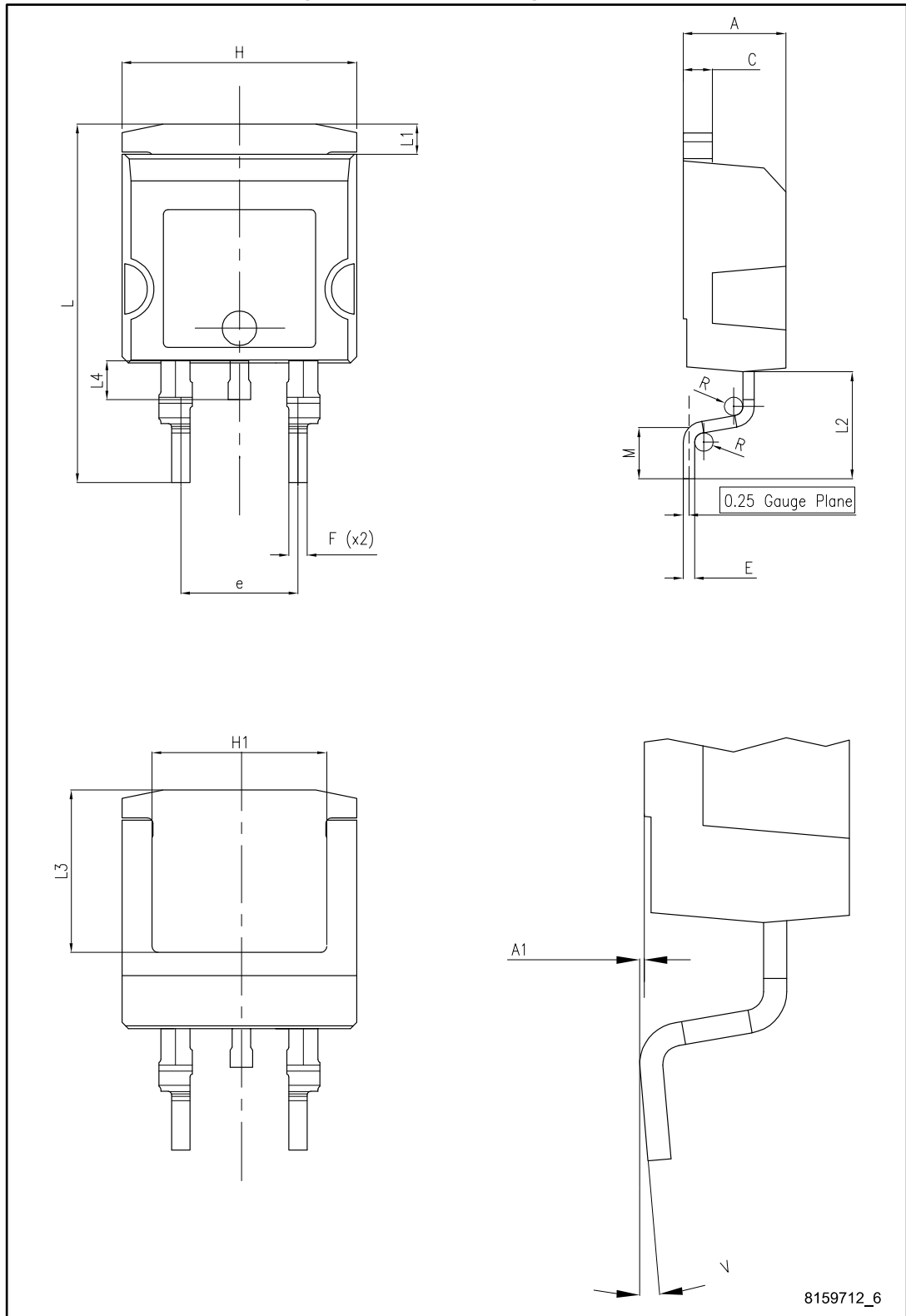
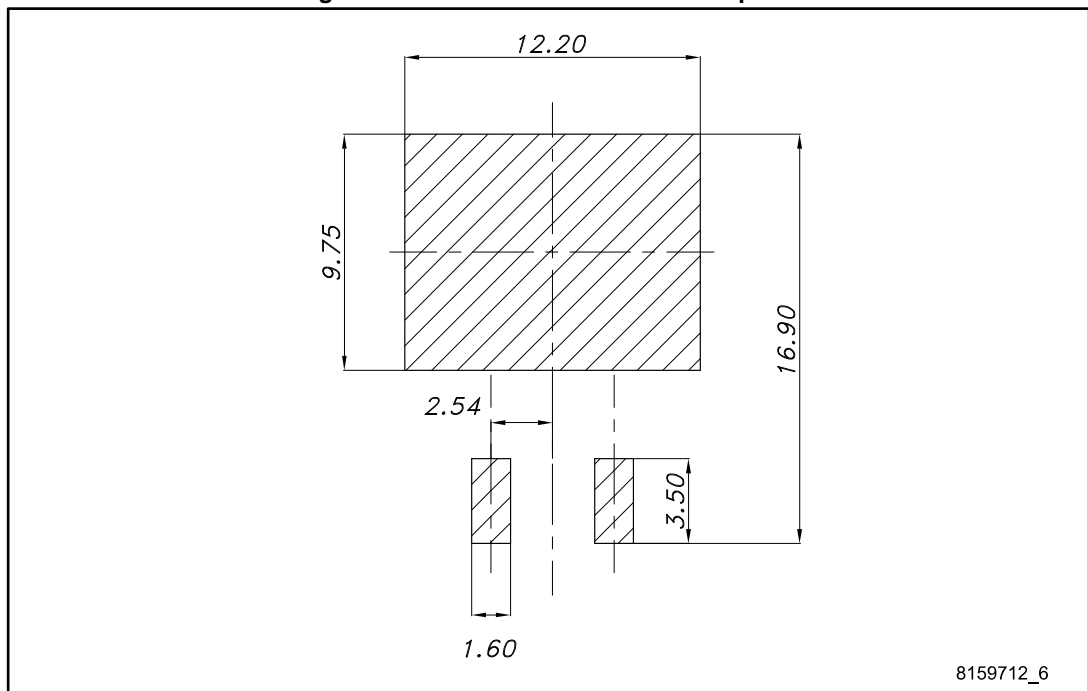


Table 8: H²PAK-2 package mechanical data

| Dim. | mm | | |
|------|-------|------|-------|
| | Min. | Typ. | Max. |
| A | 4.30 | | 4.70 |
| A1 | 0.03 | | 0.20 |
| C | 1.17 | | 1.37 |
| e | 4.98 | | 5.18 |
| E | 0.50 | | 0.90 |
| F | 0.78 | | 0.85 |
| H | 10.00 | | 10.40 |
| H1 | 7.40 | | 7.80 |
| L | 15.30 | | 15.80 |
| L1 | 1.27 | | 1.40 |
| L2 | 4.93 | | 5.23 |
| L3 | 6.85 | | 7.25 |
| L4 | 1.5 | | 1.7 |
| M | 2.6 | | 2.9 |
| R | 0.20 | | 0.60 |
| V | 0° | | 8° |

Figure 20: H²PAK-2 recommended footprint



4.2 H²PAK-2 packing information

Figure 21: Tape outline

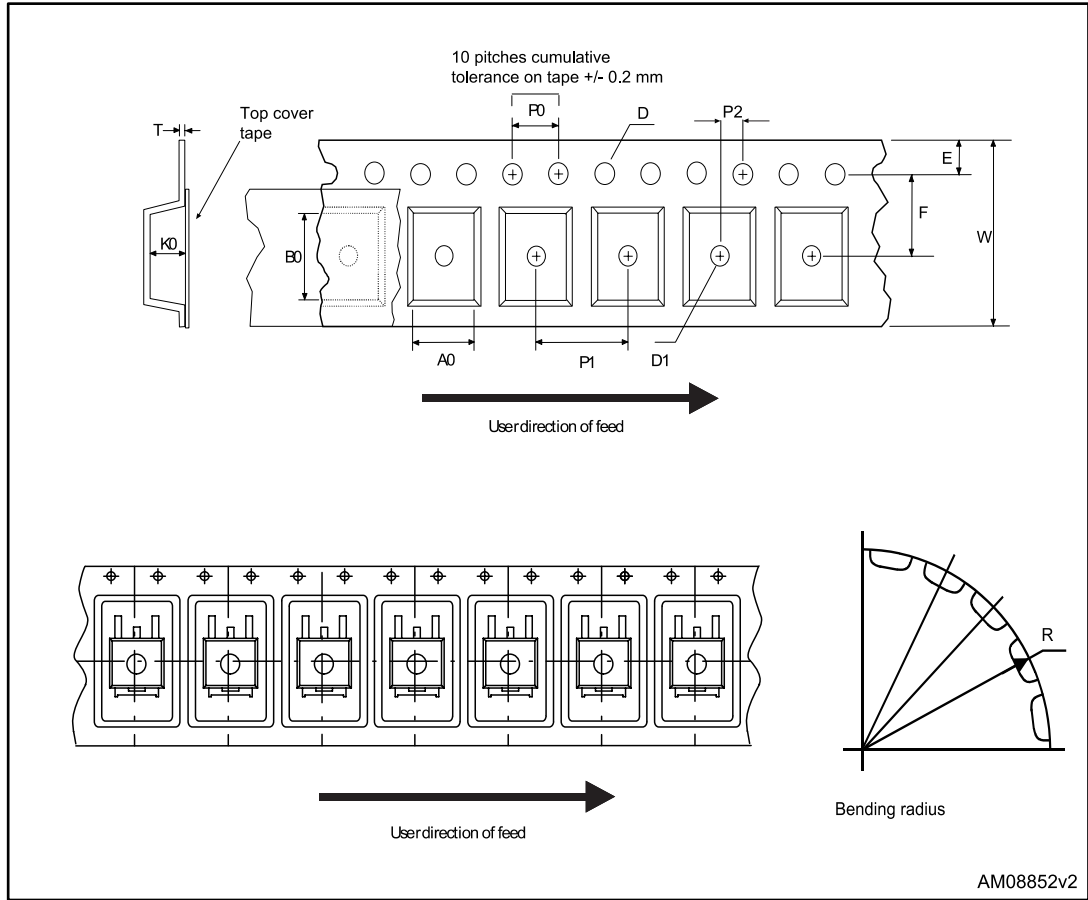


Figure 22: Reel outline

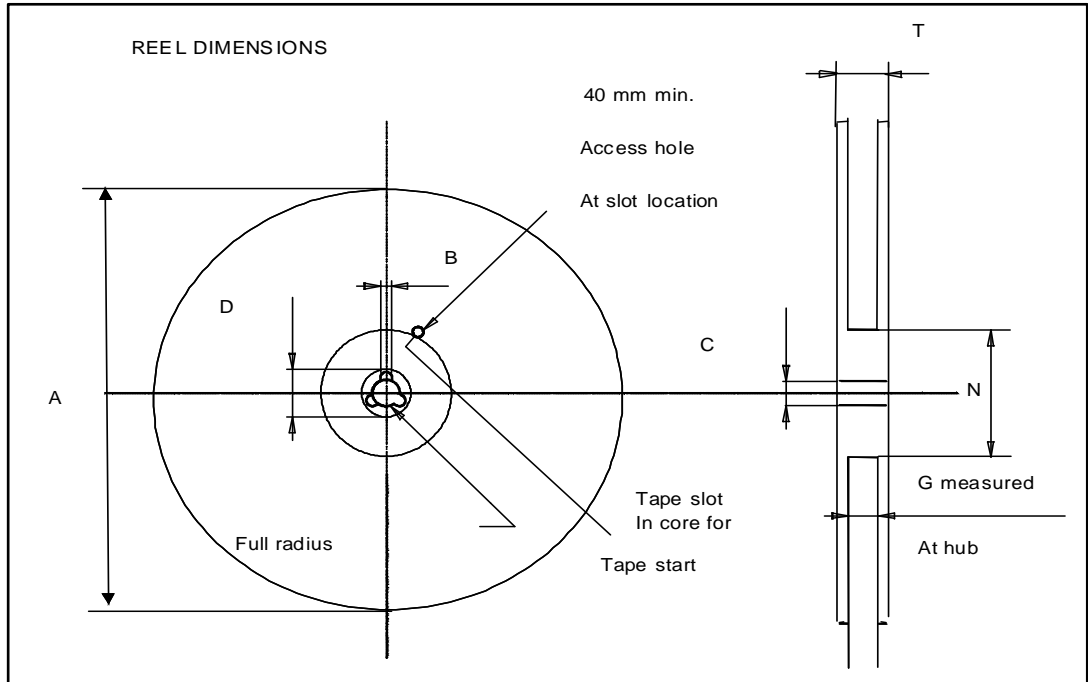


Table 9: Tape and reel mechanical data

| Tape | | | Reel | | |
|------|------|------|---------------|------|------|
| Dim. | mm | | Dim. | mm | |
| | Min. | Max. | | Min. | Max. |
| A0 | 10.5 | 10.7 | A | | 330 |
| B0 | 15.7 | 15.9 | B | 1.5 | |
| D | 1.5 | 1.6 | C | 12.8 | 13.2 |
| D1 | 1.59 | 1.61 | D | 20.2 | |
| E | 1.65 | 1.85 | G | 24.4 | 26.4 |
| F | 11.4 | 11.6 | N | 100 | |
| K0 | 4.8 | 5.0 | T | | 30.4 |
| P0 | 3.9 | 4.1 | | | |
| P1 | 11.9 | 12.1 | Base quantity | | 1000 |
| P2 | 1.9 | 2.1 | Bulk quantity | | 1000 |
| R | 50 | | | | |
| T | 0.25 | 0.35 | | | |
| W | 23.7 | 24.3 | | | |

5 Revision history

Table 10: Document revision history

| Date | Revision | Changes |
|-------------|----------|--|
| 22-Jan-2014 | 1 | First release. The part number previously included in datasheet DocID024972 |
| 25-Aug-2014 | 2 | Updated title and description in cover page. Added E _{AS} parameter in <i>Table 2: Absolute maximum ratings</i> . Minor text changes. |
| 11-Jan-2017 | 3 | Document status promoted from preliminary to production data. Minor text changes. |

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